NSi8100xC/ NSi8101xC

High Reliability Bidirectional I²C Isolators

Datasheet (EN) 1.0

Product Overview

The NSi810xC devices are low cost bidirectional isolators that are compatible with I²C interface. The NSi810xC devices are AEC-Q100 qualified. The NSi810xC devices are safety certified by UL1577 support several insulation withstand voltages (3.75kV$_{rms}$, 5kV$_{rms}$), while providing high electromagnetic immunity and low emissions at low power consumption. The I²C clock of the NSi810xC is up to 2MHz, and the common-mode transient immunity (CMTI) is up to 150kV/us. Wide supply voltage of the NSi810xC device support to connect with most digital interface directly, easy to do the level shift. High system level EMC performance enhance reliability and stability of use.

Key Features

- Up to 5000V$_{rms}$ Insulation voltage
- I²C Clock rate: up to 2MHz
- Power supply voltage: 2.5V to 5.5V
- AEC-Q100 Grade 1 qualified
- High CMTI: 150kV/us
- Chip level ESD: HBM: ±6kV
- High system level EMC performance:
  Enhanced system level ESD, EFT, Surge immunity
- Isolation barrier life: >60 years
- Low power consumption: 1.5mA/ch (1 Mbps)
- Low propagation delay: <15ns
- Operation temperature: -40℃~125℃
- RoHS-compliant packages:
  SOP8
  SOW16

Safety Regulatory Approvals

- UL recognition: up to 5000V$_{rms}$ for 1 minute per UL1577
- CQC certification per GB4943.1-2011
- CSA component notice 5A
- DIN VDE V 0884-11:2017-01

Applications

- Power over ethernet
- Isolated I²C, SMBus, or PMBus interface
- I²C level shifting
- Battery Management

Device Information

Part Number	*Package*	*Body Size*
NSI810xNC-DSPR	SOP8	6.00mm × 5.00mm
NSI810xWC-DSWR	SOW16	10.30mm × 7.50mm

Functional Block Diagrams

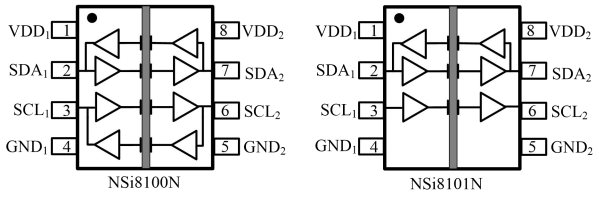


Figure 1. NSi810xNC Block Diagram

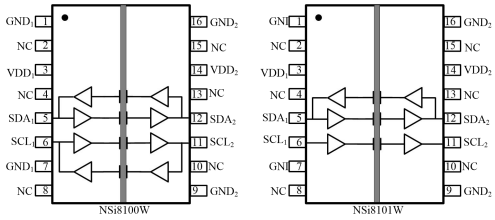


Figure 2. NSi810xWC Block Diagram

INDEX

1. Package Information

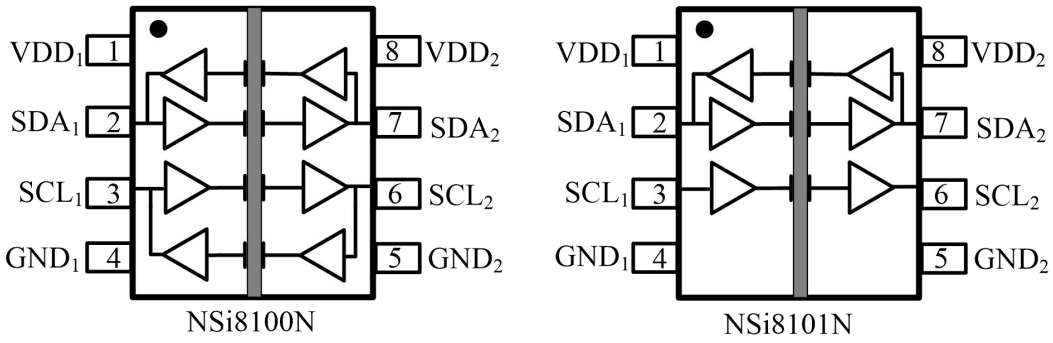


Figure 1.1 NSi8100NC/NSi8101NC Package

Table1.1 NSi8100NC/ NSi8101NC Pin Configuration and Description

NSi8100NC PIN NO.	*NSi8101NC PIN NO.*	*SYMBOL*	*FUNCTION*
1	1	VDD_1	Power Supply for Isolator Side 1
2	2	SDA_1	Serial data input /output, Side 1
3	3	SCL_1	Serial clock input /output, Side 1
4	4	GND_1	Ground 1, the ground reference for Isolator Side 1
5	5	GND_2	Ground 2, the ground reference for Isolator Side 2
6	6	SCL_2	Serial clock input /output, Side 2
7	7	SDA_2	Serial data input /output, Side 2
8	8	VDD_2	Power Supply for Isolator Side 2

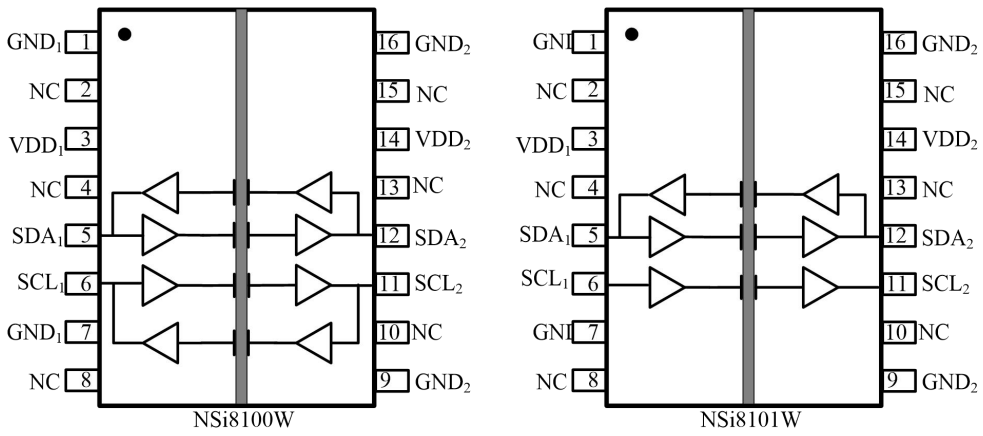


Figure 1.2 NSi8100WC/ NSi8101WC Package

Table6.2 NSi8100WC/ NSi8101WC Pin Configuration and Description

NSi8100WC PIN NO.	*NSi8101WC PIN NO.*	*SYMBOL*	*FUNCTION*

1	1	GND_1	Ground 1, the ground reference for Isolator Side 1
2	2	NC	No Connection.
3	3	VDD_1	Power Supply for Isolator Side 1
4	4	NC	No Connection.
5	5	SDA_1	Serial data input /output, Side 1
6	6	SCL_1	Serial clock input /output, Side 1
7	7	GND_1	Ground 1, the ground reference for Isolator Side 1
8	8	NC	No Connection.
9	9	GND_2	Ground 2, the ground reference for Isolator Side 2
10	10	NC	No Connection.
11	11	SCL_2	Serial clock input /output, Side 2
12	12	SDA_2	Serial data input /output, Side 2
13	13	NC	No Connection.
14	14	VDD_2	Power Supply for Isolator Side 2
15	15	NC	No Connection.
16	16	GND_2	Ground 2, the ground reference for Isolator Side 2

2. Absolute Maximum Ratings

Parameters	*Symbol*	*Min*	*Typ*	*Max*	*Unit*	*Comments*
Power Supply Voltage	VDD1, VDD2	-0.5		6.5	V	
Maximum Input Voltage	SDA_1, SDA_2, SCL_1, SCL_2	-0.4		VDD+0.4[1]	V	
Maximum Input Pulse Voltage	SDA_1, SDA_2, SCL_1, SCL_2	-0.8		VDD+0.8	V	Pulse width should be less than 100ns, and the duty cycle should be less than 10%
Output current	Io	-15		15	mA	
Maximum Surge Isolation Voltage	V_{IOSM}			5.3	kV	
Operating Temperature	Topr	-40		125	℃	
Storage Temperature	Tstg	-40		150	℃	
Electrostatic discharge	HBM			±6000	V	
	CDM			±2000	V	

[1] The maximum voltage must not exceed 6.5V.

3. Recommended Operating Conditions

Parameters	Symbol	min	typ	max	unit
Power Supply Voltage	VDD1, VDD2	2.5		5.5	V
Operating Temperature	Topr	-40		125	℃
Side1 High Level Input Voltage	VIH1	0.6			V
Side1 Low Level Input Voltage	VIL1			0.4	V
Side2 High Level Input Voltage	VIH2	2			
Side2 Low Level Input Voltage	VIL2			0.8	
Data rate	DR	0		2	Mbps

4. Thermal Characteristics

Parameters	Symbol	SOW16	SOP8	Unit
IC Junction-to-Air Thermal Resistance	θ_{JA}	86.5	137.7	℃/W
Junction-to-case (top) thermal resistance	$\theta_{JC(top)}$	49.6	54.9	℃/W
Junction-to-board thermal resistance	θ_{JB}	49.7	71.7	℃/W

5. Specifications

5.1. Electrical Characteristics

(VDD1=2.5V~5.5V, VDD2=2.5V~5.5V, Ta=-40℃ to 125℃. Unless otherwise noted, Typical values are at VDD1 = 5V, VDD2 = 5V, Ta = 25℃)

Parameters	Symbol	Min	Typ	Max	Unit	Comments
Power on Reset	VDD_{POR}		2.2		V	POR threshold as during power-up
	VDD_{HYS}		0.1		V	POR threshold Hysteresis
Start Up Time after POR	trbs		40		usec	
Common Mode Transient Immunity	CMTI	±100	±150		kV/us	
SDA,SCL logic low leakage	IIL			15	uA	
Side 1 Logic Level						
Input Threshold	V_{ILT1}	400			mV	Input Threshold at rising edge
	V_{IHT1}			600	mV	
	V_{IT_HYS1}		100		mV	Input Threshold Hysteresis
Low Level Output Voltage	V_{OL1}	650		800	mV	I_{OL} ≤ 4mA， $R_{PULL\ UP}$=1K

Low-level output voltage to high-level input voltage threshold difference	ΔV_{OIT1}	70			mV	
Side 2 Logic Level						
Input Threshold	V_{ILT2}		1.6		V	Input Threshold at rising edge
	V_{IT_HYS2}		0.4		V	Input Threshold Hysteresis
High Level Input Voltage	V_{IH2}	2.0			V	
Low Level Input Voltage	V_{IL2}			0.8	V	
Low Level Output Voltage	V_{OL}			0.5	V	I_{OL} ≤ 30mA

(VDD1=5V± 10%, VDD2=5V± 10%, Ta=-40℃ to 125℃. Unless otherwise noted, Typical values are at VDD1 = 5V, VDD2 = 5V, Ta = 25℃)

Parameters	*Symbol*	*Min*	*Typ*	*Max*	*Unit*	*Comments*
Supply current	**NSi8100C**					
	I_{DD1}(Q0)		5.10	7.5	mA	All Input 0V
	I_{DD2}(Q0)		3.96	5.7	mA	
	I_{DD1}(Q1)		2.52	3.6	mA	All Input at supply
	I_{DD2}(Q1)		1.78	2.5	mA	
	I_{DD1}(2M)		3.83	5.7	mA	All Input with 2MHz, C_L=15pF
	I_{DD2}(2M)		2.78	4.2	mA	
	NSi8101C					
	I_{DD1}(Q0)		4.08	6.12	mA	All Input 0V
	I_{DD2}(Q0)		2.81	4.22	mA	
	I_{DD1}(Q1)		1.6	2.4	mA	All Input at supply
	I_{DD2}(Q1)		1.69	2.54	mA	
	I_{DD1}(2M)		2.65	3.98	mA	All Input with 2MHz, C_L=15pF
	I_{DD2}(2M)		4	6	mA	
Clock rate	DR	0		2	MHz	
Propagation Delay	t_{PLH12}		24.8	37.2	ns	See figure 2.6, R1=1500Ω，R2=500Ω, NO LOAD
	t_{PHL12}		32.8	49.2	ns	See figure 2.6, R1=1500Ω，R2=500Ω, NO LOAD
	t_{PLH21}		24	36	ns	See figure 2.6,

						R1=1500Ω，R2=500Ω, NO LOAD
	t_{PHL21}		38	57	ns	See figure 2.6, R1=1500Ω，R2=500Ω, NO LOAD
Pulse Width Distortion	PWD_{12}		8	12	ns	$\lvert t_{PHL12} - t_{PLH12} \rvert$
	PWD_{21}		14	21	ns	$\lvert t_{PHL21} - t_{PLH21} \rvert$
Falling Time	t_{f1}		10.6	15.9	ns	C_L = 30pF
	t_{f2}		22.8	34.2	ns	C_L = 300pF

(VDD1=3.3V± 10%, VDD2=3.3V± 10%, Ta=-40℃ to 125℃. Unless otherwise noted, Typical values are at VDD1 = 3.3V, VDD2 = 3.3V, Ta = 25℃)

Parameters	*Symbol*	*Min*	*Typ*	*Max*	*Unit*	*Comments*
Supply current	**NSi8100C**					
	I_{DD1}(Q0)		4.96	7.4	mA	All Input 0V
	I_{DD2}(Q0)		3.85	5.6	mA	
	I_{DD1}(Q1)		2.40	3.5	mA	All Input at supply
	I_{DD2}(Q1)		1.68	2.4	mA	
	I_{DD1}(2M)		3.69	5.6	mA	All Input with 2MHz, C_L=15pF
	I_{DD2}(2M)		2.67	4.2	mA	
	NSi8101C					
	I_{DD1}(Q0)		4	6	mA	All Input 0V
	I_{DD2}(Q0)		2.72	4.08	mA	
	I_{DD1}(Q1)		1.53	2.3	mA	All Input at supply
	I_{DD2}(Q1)		1.61	2.42	mA	
	I_{DD1}(2M)		2.68	4.02	mA	All Input with 2MHz, C_L=15pF
	I_{DD2}(2M)		3.48	5.22	mA	
Clock rate	DR	0		2	MHz	
Propagation Delay	t_{PLH12}		29	43.5	ns	See figure 2.6, R1=1500Ω，R2=500Ω, NO LOAD
	t_{PHL12}		39.8	59.7	ns	See figure 2.6, R1=1500Ω，R2=500Ω, NO LOAD

	t_{PLH21}		30	45	ns	See figure 2.6, R1=1500Ω，R2=500Ω, NO LOAD
	t_{PHL21}		61	91.5	ns	See figure 2.6, R1=1500Ω，R2=500Ω, NO LOAD
Pulse Width Distortion	PWD_{12}		10.8	16.2	ns	$\lvert t_{PHL12} - t_{PLH12} \rvert$
	PWD_{21}		31	46.5	ns	$\lvert t_{PHL21} - t_{PLH21} \rvert$
Falling Time	t_{f1}		15.6	23.4	ns	C_L = 30pF
	t_{f2}		32	48	ns	C_L = 300pF

(VDD1=2.5V± 10%, VDD2=2.5V± 10%, Ta=-40℃ to 125℃. Unless otherwise noted, Typical values are at VDD1 = 2.5V, VDD2 = 2.5V, Ta = 25℃)

Parameters	*Symbol*	*Min*	*Typ*	*Max*	*Unit*	*Comments*
Supply current	**NSi8100C**					
	I_{DD1}(Q0)		4.89	7.3	mA	All Input 0V
	I_{DD2}(Q0)		3.79	5.5	mA	
	I_{DD1}(Q1)		2.34	3.4	mA	All Input at supply
	I_{DD2}(Q1)		1.63	2.3	mA	
	I_{DD1}(2M)		3.61	5.4	mA	All Input with 2MHz, C_L=15pF
	I_{DD2}(2M)		2.59	4	mA	
	NSi8101C					
	I_{DD1}(Q0)		3.95	5.93	mA	All Input 0V
	I_{DD2}(Q0)		2.67	4.01	mA	
	I_{DD1}(Q1)		1.5	2.25	mA	All Input at supply
	I_{DD2}(Q1)		1.57	2.36	mA	
	I_{DD1}(2M)		2.81	4.21	mA	All Input with 2MHz, C_L=15pF
	I_{DD2}(2M)		2.86	4.28	mA	
Clock rate	DR	0		2	MHz	
Propagation Delay	t_{PLH12}		33	49.5	ns	See figure 2.6, R1=1500Ω，R2=500Ω, NO LOAD
	t_{PHL12}		52	78	ns	See figure 2.6, R1=1500Ω，R2=500Ω,

						NO LOAD
	t_{PLH21}		47	70.5	ns	See figure 2.6, R1=1500Ω，R2=500Ω, NO LOAD
	t_{PHL21}		100	150	ns	See figure 2.6, R1=1500Ω，R2=500Ω, NO LOAD
Pulse Width Distortion	PWD_{12}		19	28.5	ns	$\lvert t_{PHL12} - t_{PLH12} \rvert$
	PWD_{21}		53	79.5	ns	$\lvert t_{PHL21} - t_{PLH21} \rvert$
Falling Time	t_{f1}		22	33	ns	C_L = 30pF
	t_{f2}		36	54	ns	C_L = 300pF

5.2. Typical Performance Characteristics

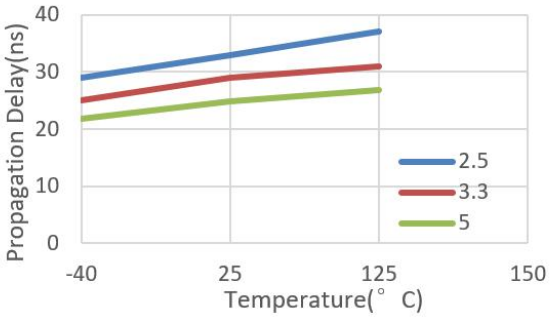


Figure 5.1 Rising Edge Propagation Delay Vs Temp

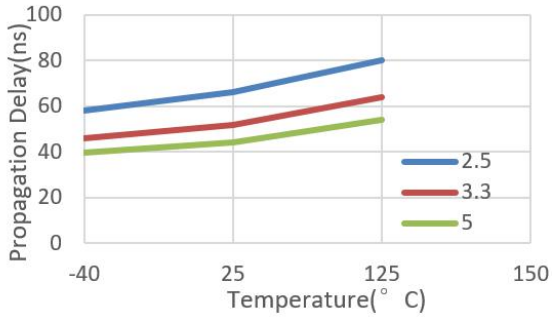


Figure 5.2 Falling Edge Propagation Delay Vs Temp

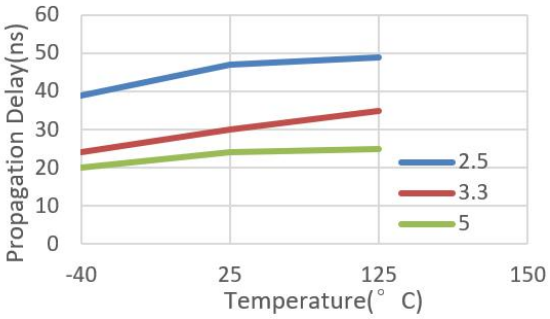


Figure 5.3 Rising Edge Propagation Delay Vs Temp

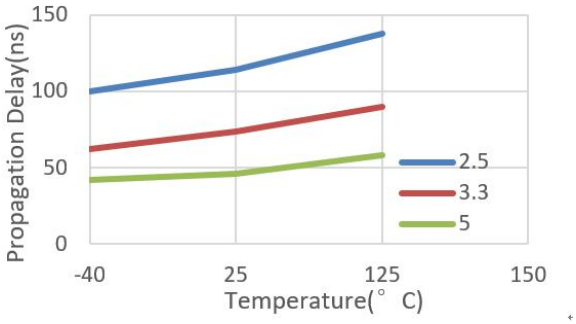
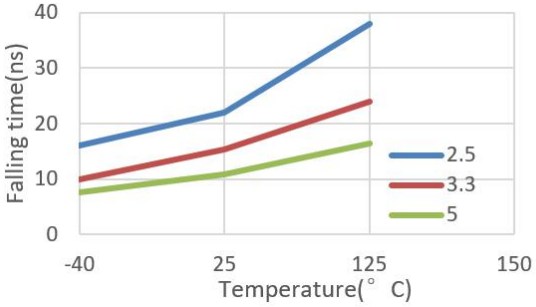


Figure 5.4 Falling Edge Propagation Delay Vs Temp



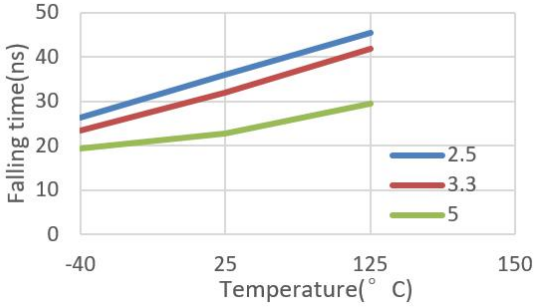


Figure 5.5 Falling time(@27pF) Vs Temp

Figure 5.6 Falling time(@300pF) Vs Temp

5.3. Parameter Measurement Information

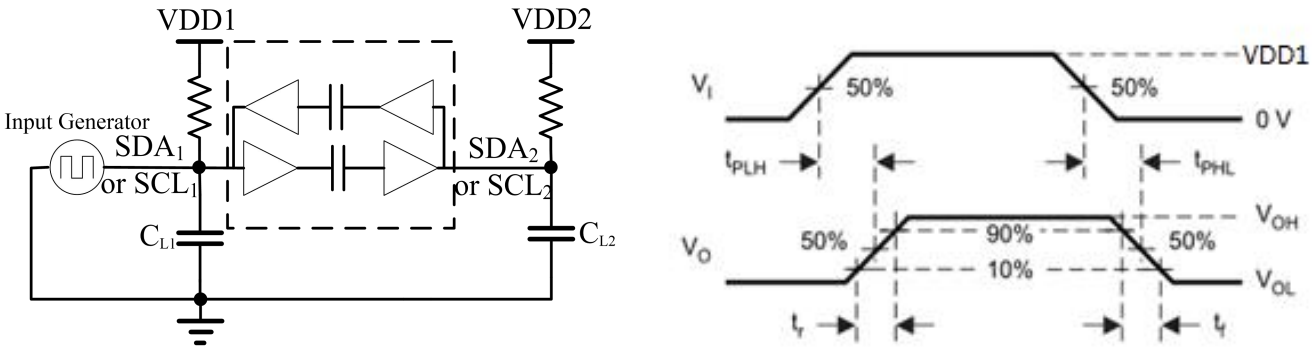


Figure 5.7 Switching Characteristic Test Circuit and Voltage Waveforms

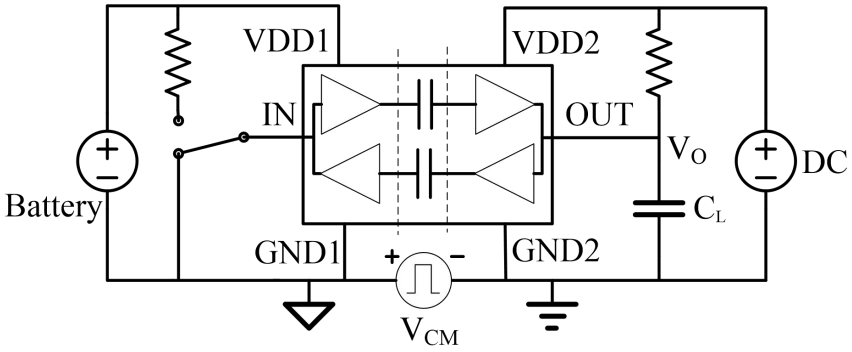


Figure 5.8 Common-Mode Transient Immunity Test Circuit

6. High Voltage Feature Description

6.1. Insulation And Safety Related Specifications

Parameters	*Symbol*	*Value*		*Unit*	*Comments*
		SOP8	*SOW16*		
Minimum External Air Gap (Clearance)	L(I01)	4.0	8.0	mm	Shortest terminal-to-terminal distance through air
Minimum External Tracking (Creepage)	L(I02)	4.0	8.0	mm	Shortest terminal-to-terminal distance across the package surface
Minimum internal gap	DTI	20		um	Distance through insulation
Tracking Resistance(Comparative Tracking Index)	CTI	>400		**V**	DIN EN 60112 (VDE 0303-11); IEC 60112
Material Group		Ⅱ			

6.2. DIN VDE V 0884-11（VDE V 0884-11）:2017-01 INSULATION CHARATERISTICS

Description	*Test Condition*	*Symbol*	*Value*		*Unit*
			SOP8	SOW16	
Installation Classification per DIN VDE 0110					
For Rated Mains Voltage ≤ 150V_{rms}			Ⅰ to Ⅳ	Ⅰ to Ⅳ	
For Rated Mains Voltage ≤ 300V_{rms}			Ⅰ to Ⅲ	Ⅰ to Ⅳ	
For Rated Mains Voltage ≤ 400V_{rms}			Ⅰ to Ⅲ	Ⅰ to Ⅳ	
Climatic Classification			10/105/21	10/105/21	
Pollution Degree per DIN VDE 0110, Table 1			2	2	
Maximum repetitive isolation voltage		V_{IORM}	565	1166	Vpeak
Maximum working isolation voltage	AC	V_{IOWM}	400	824	Vrms
	DC		565	1166	Vpeak
Input to Output Test Voltage, Method B1	$V_{IORM} \times 1.5 = V_{pd(m)}$, 100% production test, $t_{ini} = t_m = 1$ sec, partial discharge < 5 pC	$V_{pd(m)}$	847	1749	Vpeak
Input to Output Test Voltage, Method A					
After Environmental Tests Subgroup 1	$V_{IORM} \times 1.2 = V_{pd(m)}$, t_{ini} = 60 sec, t_m = 10 sec, partial discharge < 5 pC	$V_{pd(m)}$	678	1399	Vpeak
After Input and /or Safety Test Subgroup 2 and Subgroup 3	$V_{IORM} \times 1.2 = V_{pd(m)}$, t_{ini} = 60 sec, t_m = 10 sec, partial discharge < 5 pC	$V_{pd(m)}$	678	1399	Vpeak
Maximum transient isolation voltage	t = 60 sec	V_{IOTM}	5300	7000	Vpeak
Maximum Surge Isolation Voltage	Test method per IEC60065,1.2/50us waveform, $V_{TEST}=1.3\times V_{IOSM}$	V_{IOSM}	5384	5384	Vpeak
Isolation resistance	V_{IO} =500V	R_{IO}	>10^9	>10^9	Ω
Isolation capacitance	f = 1MHz	C_{IO}	0.6	0.6	pF
Input capacitance		C_I	2	2	pF
Total Power Dissipation at 25℃		Ps		1499	mW
Safety input, output, or supply current	θ_{JA} = 140 ℃/W, V_I = 5.5 V, T_J = 150 ℃, T_A = 25 ℃	Is	160		mA
	θ_{JA} = 84 ℃/W, V_I = 5.5 V, T_J = 150 ℃, T_A = 25 ℃			237	mA

Case Temperature		Ts	150	150	℃

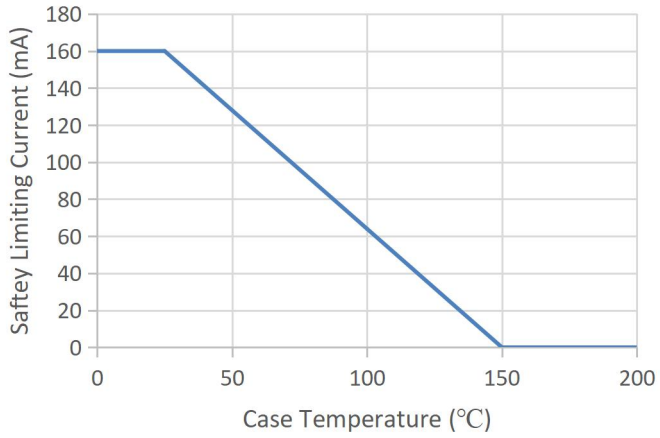
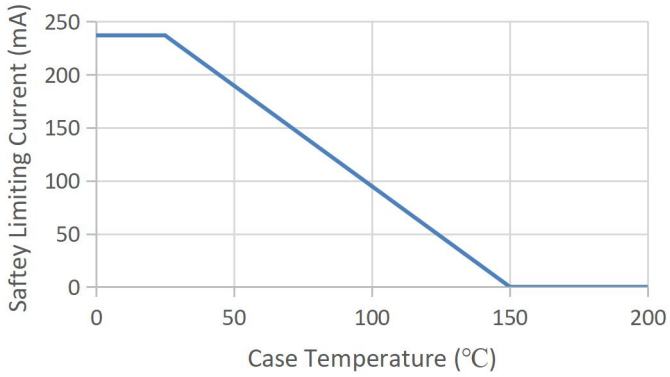


Figure 6.1 NSi8100NC/NSi8101NC Thermal Derating Curve, Dependence of Safety Limiting Values with Case Temperature per DIN VDE V 0884-



11

Figure 6.2 NSi8100WC/NSi8101WC Thermal Derating Curve, Dependence of Safety Limiting Values with Case Temperature per DIN VDE V 0884-11

6.3. Regulatory Information

The NSi8100NC/NSi8101NC are approved by the organizations listed in table.

CUL		***VDE***	***CQC***
UL 1577 Component Recognition Program[1]	Approved under CSA Component Acceptance Notice 5A	DIN VDE V 0884-11(VDE V 0884-11):2017-01[2]	Certified by CQC11-471543-2012 GB4943.1-2011
Single Protection, 3750V_{rms} Isolation voltage	Single Protection, 3750V_{rms} Isolation voltage	Basic Insulation 565Vpeak, V_{IOSM}=5384Vpeak	Basic insulation at 400V_{rms} (565Vpeak)
File (E500602)	File (E500602)	File (5024579-4880-0001)	File (pending)

[1] In accordance with UL 1577, each NSi8100NC/NSi8101NC is proof tested by applying an insulation test voltage ≥ 4500 V_{rms} for 1 sec.

[2] In accordance with DIN VDE V 0884-11, each NSi8100NC/NSi8101NC is proof tested by applying an insulation test voltage ≥ 847 V peak for 1 sec (partial discharge detection limit = 5 pC). The * marking branded on the component designates DIN VDE V 0884-11.

The NSi8100WC/NSi8101WC are approved by the organizations listed in table.

CUL		VDE	CQC
UL 1577 Component Recognition Program[1]	Approved under CSA Component Acceptance Notice 5A	DIN VDE V 0884-11(VDE V 0884-11):2017-01[2]	Certified by CQC11-471543-2012 GB4943.1-2011
Single Protection, 5000V_{rms} Isolation voltage	Single Protection, 5000V_{rms} Isolation voltage	Basic Insulation 849Vpeak, V_{IOSM}=5384Vpeak	Basic insulation at 800V_{RMS} (1131Vpeak) Reinforced insulation at 400V_{rms} (565Vpeak)
File (E500602)	File (E500602)	File (5024579-4880-0001)	File (pending)

[1] In accordance with UL 1577, each NSi8100WC/NSi8101WC is proof tested by applying an insulation test voltage ≥ 6000 V rms for 1 sec.

[2] In accordance with DIN VDE V 0884-11, each NSi8100WC/NSi8101WC is proof tested by applying an insulation test voltage ≥ 1273 V peak for 1 sec (partial discharge detection limit = 5 pC). The * marking branded on the component designates DIN VDE V 0884-11 approval.

7. Function Description

The NSi810xC is a bidirectional isolator based on a capacitive isolation barrier technique. The NSi810xC devices are compatible with I^2C interface. Internally, the I^2C interface is split into two unidirectional channels communicating in opposing directions via a dedicate capacitive isolation channel for each. The digital signal is modulated with RF carrier generated by the internal oscillator at the Transmitter side. Then it is transferred through the capacitive isolation barrier and demodulated at the Receiver side.

The NSi8100C devices are high reliability dual-channel bidirectional isolators for clock and data lines while NSi8101 has a bidirectional data and a unidirectional clock channel. The NSi8100C is suitable for multi-master application while NSi8101 is useful in a single master application.

The Side 2 logic levels of NSi810xC are standard I^2C value, and the maximum load for side 2 is ≤ 400pF. So multiple NSi810xC devices connected to a bus by their Side 2 pins can communicate with each other and with other I^2C compatible devices.

The Side 1 logic levels of NSi810xC are not standard value. The output low level of NSi810 x is 650mV, while low-level output voltage to high-level input voltage threshold is 50mV. This prevents an output logic low at Side 1 being transmitted back to Side 2 and pulling down the I^2C bus.

The NSi810xC devices are AEC-Q100 qualified. The NSi810xC device is safety certified by UL1577 support several insulation withstand voltages (3.75kV_{rms}, 5kV_{rms}), while providing high electromagnetic immunity and low emissions at low power consumption. The I^2C clock of the NSi810xC is up to 2MHz, and the common-mode transient immunity (CMTI) is up to 150kV/us. Wide supply voltage of the NSi810xC device support to connect with most digital interface directly, easy to do the level shift. High system level EMC performance enhance reliability and stability of use.

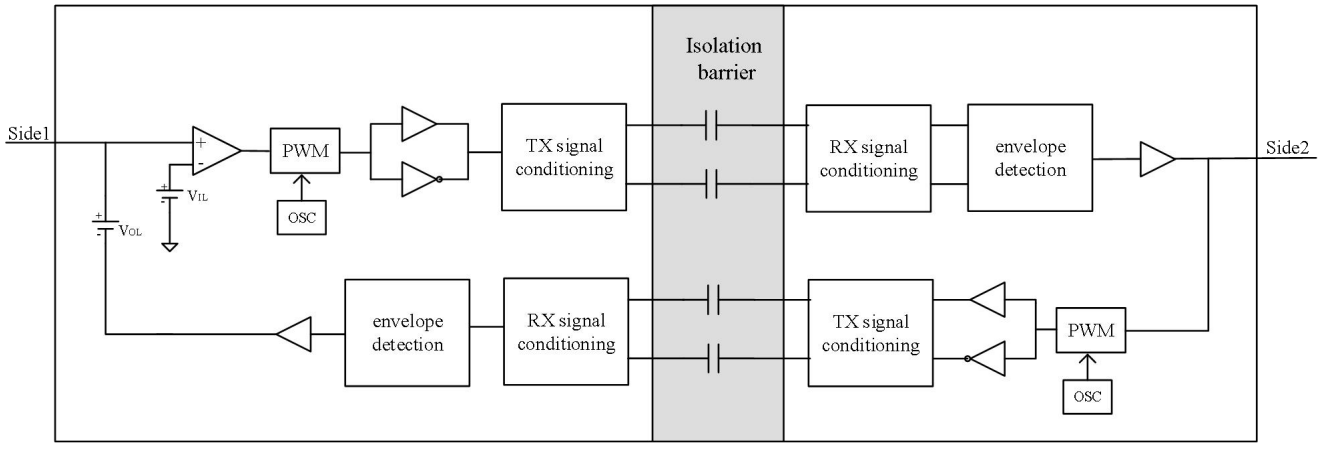


Figure 7.1 Simplified Channel Diagram

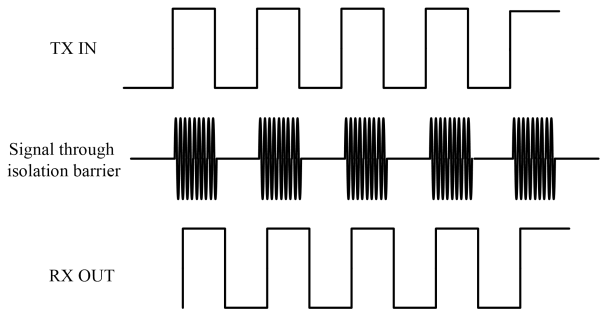


Figure 7.2 OOK Based Modulation Scheme

The Table 4.1 shows the functional of NSi810xC.The NSi810xC is high impedance output when VDDIN is unready and VDDOUT is ready as shown in.

Table 4.1 Output status vs. power status

Input	*VDD1 status*	*VDD2 status*	*Output*	*Comment*
H	Ready	Ready	Z	Normal operation.
L	Ready	Ready	L	
X	Unready	Ready	Z	The output follows the same status with the input within 60us after input side VDD1 is powered on.
X	Ready	Unready	X	The output follows the same status with the input within 60us after output side VDD2 is powered on.

8. Application Note

8.1. Pcb Layout

The NSi810xC requires a 0.1 µF bypass capacitor between VDD1 and GND1, VDD2 and GND2. The capacitor should be placed as close as possible to the package. Figure 5.1 to Figure 5.4 show the recommended PCB layout, make sure the space under the chip should keep free from planes, traces, pads and via. The pull-up resistors required for both Side 1 and Side 2 buses. And the value of the resistors depend on the number of I^2C devices on the bus.

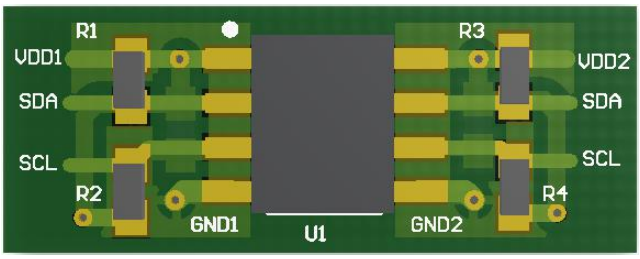


Figure8.1 Recommended PCB Layout — Top Layer

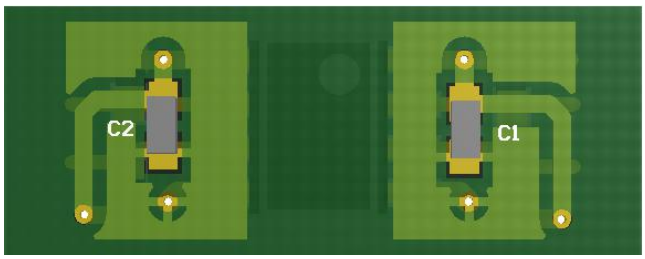


Figure8.2 Recommended PCB Layout — Bottom Layer

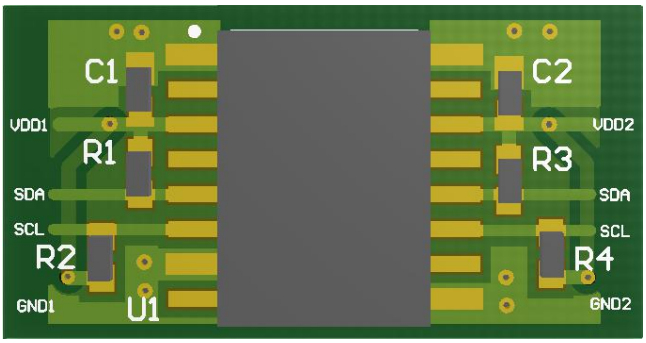


Figure8.3 Recommended PCB Layout — Top Layer

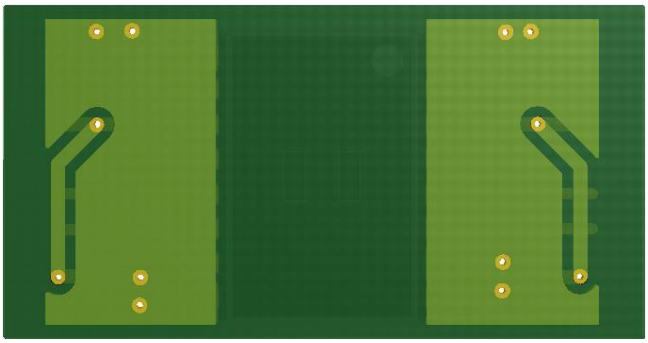
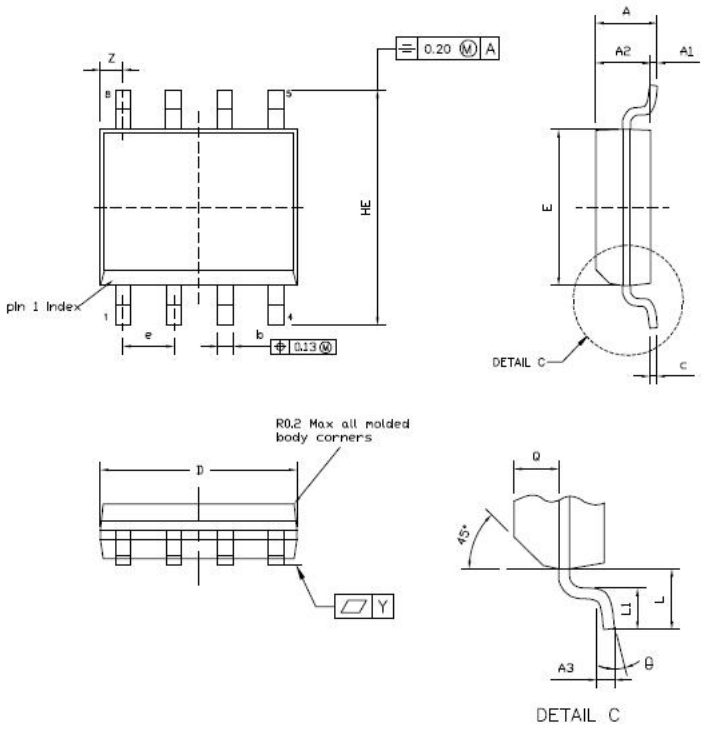


Figure8.4 Recommended PCB Layout — Bottom Layer

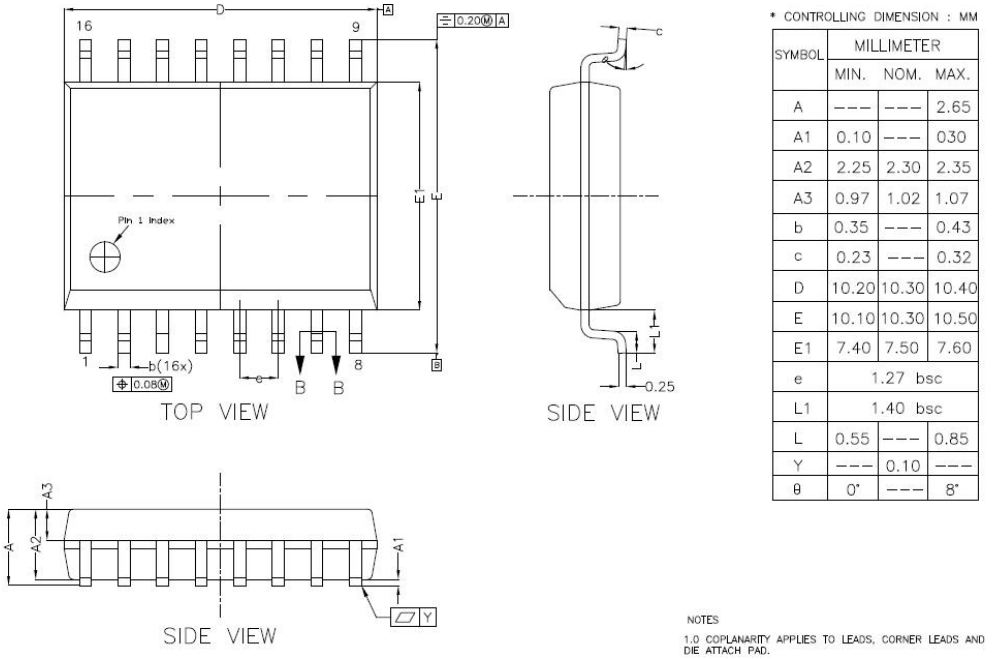
9. Package Information



* CONTROLLING DIMENSION : MM

SYMBOL	MILLIMETER		
	MIN.	NOM.	MAX.
A	---	---	1.75
A1	0.10	---	0.25
A2	1.25	1.35	1.45
b	0.33	0.38	0.49
c	0.19	0.20	0.25
D	4.80	4.90	5.00
E	3.80	3.90	4.00
Q	0.60	0.65	0.70
HE	5.80	6.00	6.20
e	1.27 BSC		
L	1.05 BSC		
L1	0.40	0.64	1.00
Y	---	0.10	---
Z	0.3	0.5	0.7
A3	0.25 BSC		
θ	0°	5°	8°

Figure 9.1 SOP8 Package Shape and Dimension in millimeters



* CONTROLLING DIMENSION : MM

SYMBOL	MILLIMETER		
	MIN.	NOM.	MAX.
A	---	---	2.65
A1	0.10	---	030
A2	2.25	2.30	2.35
A3	0.97	1.02	1.07
b	0.35	---	0.43
c	0.23	---	0.32
D	10.20	10.30	10.40
E	10.10	10.30	10.50
E1	7.40	7.50	7.60
e	1.27 bsc		
L1	1.40 bsc		
L	0.55	---	0.85
Y	---	0.10	---
θ	0°	---	8°

NOTES

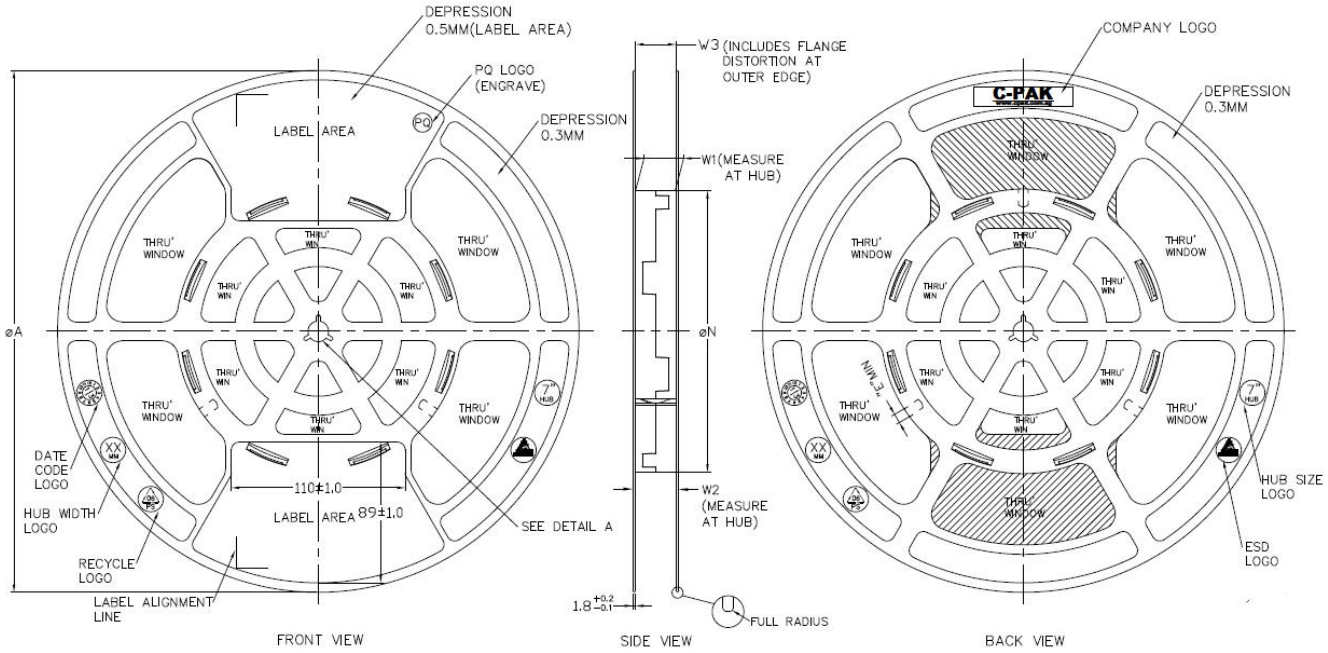
1.0 COPLANARITY APPLIES TO LEADS, CORNER LEADS AND DIE ATTACH PAD.

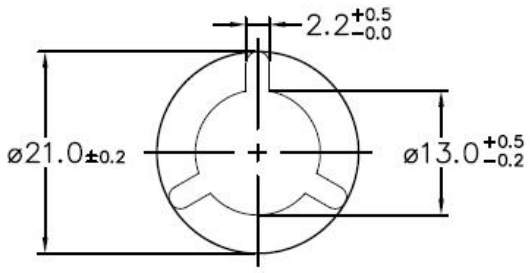
Figure 9.2 SOW16 Package Shape and Dimension in millimeters

10. Order Information

Part No.	*Isolation Rating(kV)*	*Number of side 1 inputs*	*Number of side 2 inputs*	*Max Clock Rate (MHz)*	*Temperature*	*MSL*	*Automotive*	*Package*	*SPQ*
NSi8100NC	3.75	2	2	2	-40 to 125℃	3	NO	SOP8	2500
NSi8101NC	3.75	2	1	2	-40 to 125℃	3	NO	SOP8	2500
NSi8100WC	5	2	2	2	-40 to 125℃	2	NO	SOW16	1000
NSi8101WC	5	2	1	2	-40 to 125℃	2	NO	SOW16	1000
NOTE: All packages are RoHS-compliant with peak reflow temperatures of 260 ℃ according to the JEDEC industry standard classifications and peak solder temperatures. All devices are AEC-Q100 qualified.									

11. Tape and Reel Information

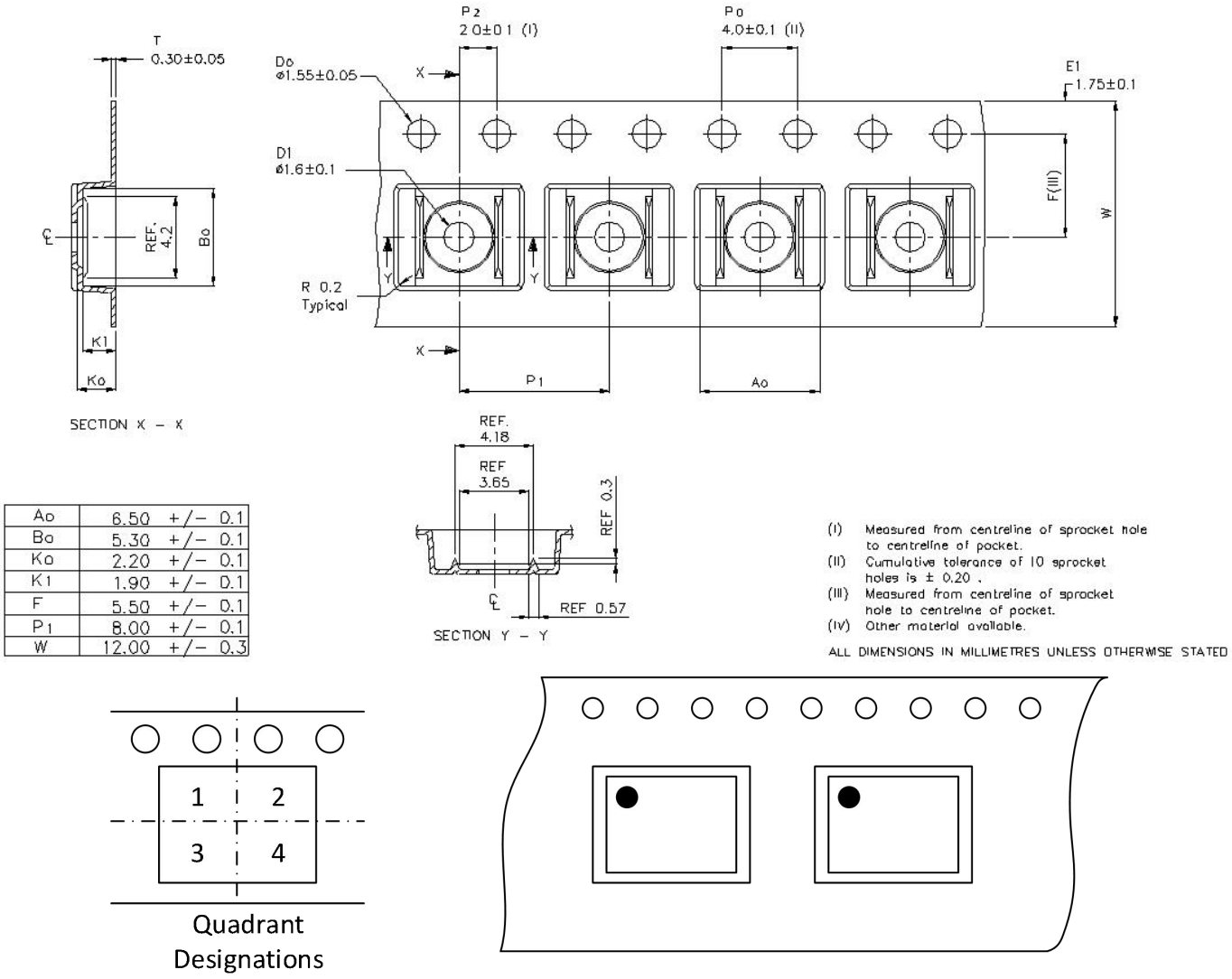




ARBOR HOLE
DETAIL A
SCALE : 3:1

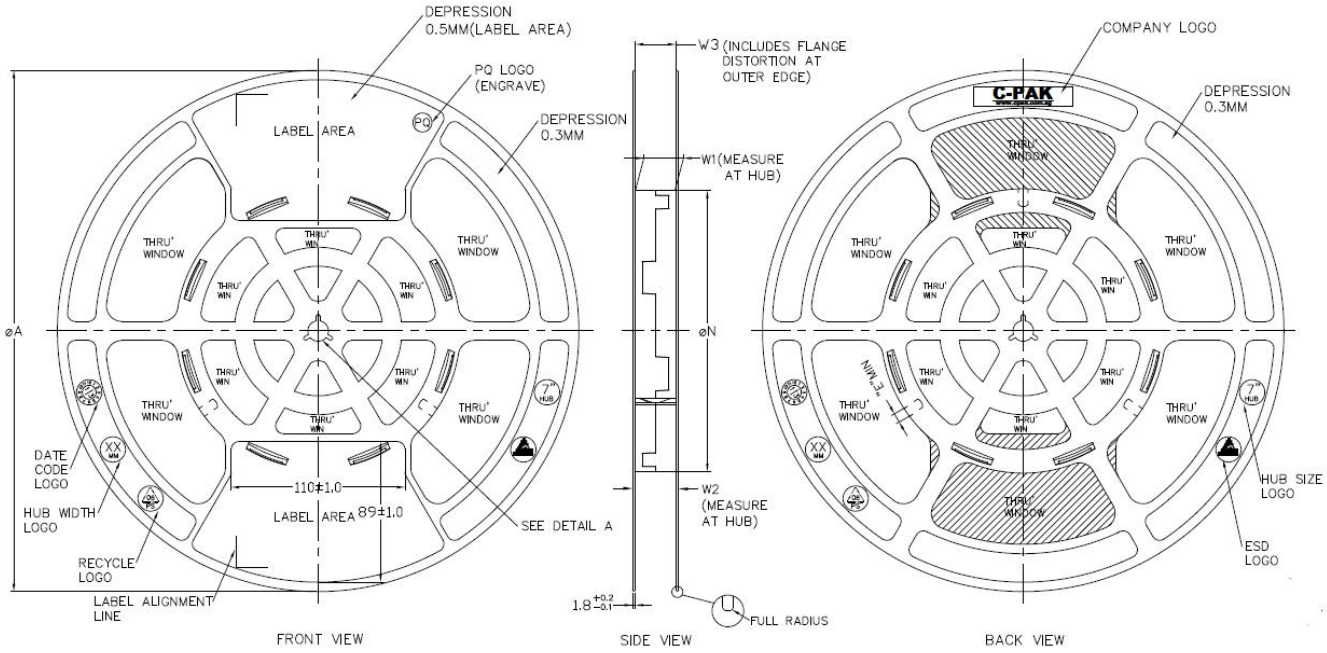
PRODUCT SPECIFICATION						
TAPE WIDTH	øA ±2.0	øN ±2.0	W1	W2 (MAX)	W3	E (MIN)
08MM	330	178	8.4 +1.5 −0.0	14.4	SHALL ACCOMMODATE TAPE WIDTH WITHOUT INTERFERENCE	5.5
12MM	330	178	12.4 +2.0 −0.0	18.4		5.5
16MM	330	178	16.4 +2.0 −0.0	22.4		5.5
24MM	330	178	24.4 +2.0 −0.0	30.4		5.5
32MM	330	178	32.4 +2.0 −0.0	38.4		5.5

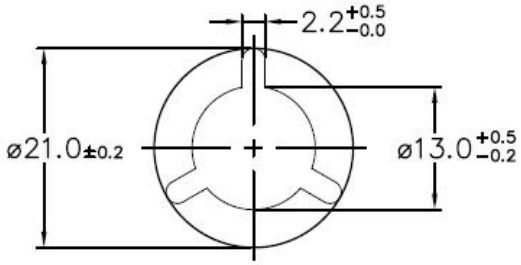
SURFACE RESISTIVITY			
LEGEND	SR RANGE	TYPE	COLOUR
A	BELOW 10^{12}	ANTISTATIC	ALL TYPES
B	10^{6} TO 10^{11}	STATIC DISSIPATIVE	BLACK ONLY
C	10^{5} & BELOW 10^{5}	CONDUCTIVE (GENERIC)	BLACK ONLY
E	10^{9} TO 10^{11}	ANTISTATIC (COATED)	ALL TYPES



Ao	6.50 +/– 0.1
Bo	5.30 +/– 0.1
Ko	2.20 +/– 0.1
K1	1.90 +/– 0.1
F	5.50 +/– 0.1
P1	8.00 +/– 0.1
W	12.00 +/– 0.3

Figure 11.1 Tape and Reel Information of SOP8

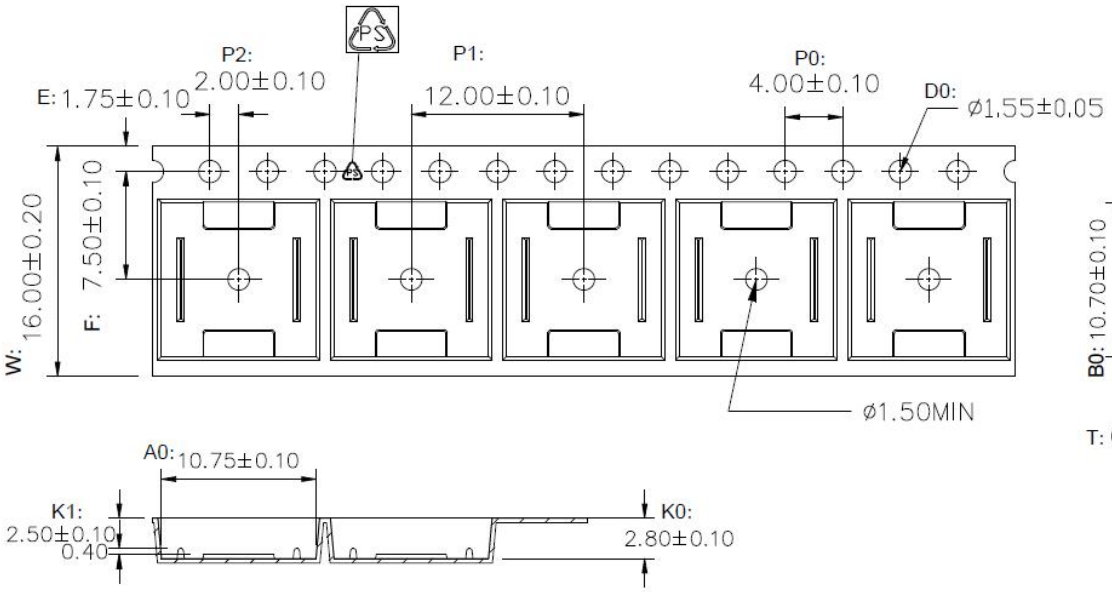




ARBOR HOLE
DETAIL A
SCALE : 3:1

PRODUCT SPECIFICATION						
TAPE WIDTH	øA ±2.0	øN ±2.0	W1	W2 (MAX)	W3	E (MIN)
08MM	330	178	8.4 +1.5 −0.0	14.4	SHALL ACCOMMODATE TAPE WIDTH WITHOUT INTERFERENCE	5.5
12MM	330	178	12.4 +2.0 −0.0	18.4		5.5
16MM	330	178	16.4 +2.0 −0.0	22.4		5.5
24MM	330	178	24.4 +2.0 −0.0	30.4		5.5
32MM	330	178	32.4 +2.0 −0.0	38.4		5.5

SURFACE RESISTIVITY			
LEGEND	SR RANGE	TYPE	COLOUR
A	BELOW 10^{12}	ANTISTATIC	ALL TYPES
B	10^{6} TO 10^{11}	STATIC DISSIPATIVE	BLACK ONLY
C	10^{5} & BELOW 10^{5}	CONDUCTIVE (GENERIC)	BLACK ONLY
E	10^{9} TO 10^{11}	ANTISTATIC (COATED)	ALL TYPES



1. 10 sprocket hole pitch cumulative tolerance ±0.20 .
2. Carrier camber is within 1 mm in 250 mm.
3. Material : Black Conductive Polystyrene Alloy .
4. All dimensions meet EIA-481 requirements.
5. Thickness : 0.30±0.05mm.
6. Packing length per 22" reel : 378 Meters.(復卷 N=122）
7. Component load per 13" reel : 1000 pcs.
8. Surface resistivity : 10^{5} ~ 10^{10} Ω/□

RoHS

W	16.00±0.20
A0	10.75±0.10
B0	10.70±0.10
K0	2.80±0.10
K1	2.50±0.10

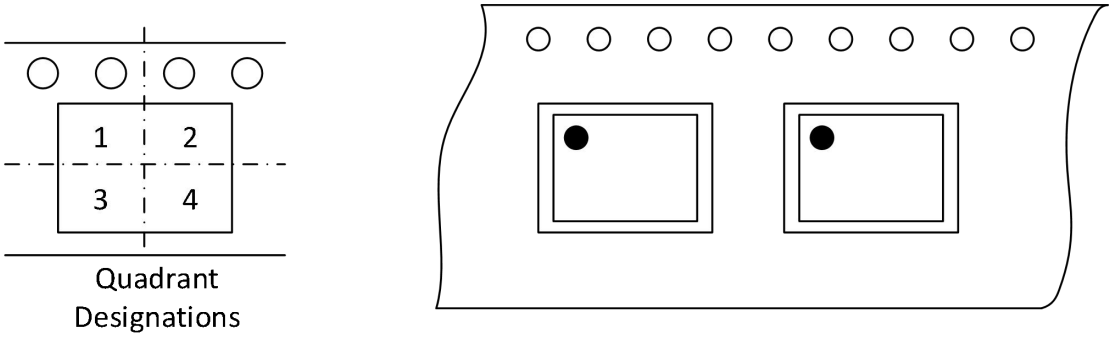


Figure 11.2 Tape and Reel Information of SOW16

12. Revision History

Revision	Description	Date
1.0	Original	2021/6/21